This document is confidential and is proprietary to the American Chemical Society and its authors. Do not copy or disclose without written permission. If you have received this item in error, notify the sender and delete all copies.

Nanoporous Silica-Alumina Films Fabricated on Silicon Photonic Chips for Selective Ammonia Sensing

Journal:	ACS Applied Nano Materials
Manuscript ID	an-2022-02741d.R3
Manuscript Type:	Article
Date Submitted by the Author:	17-Oct-2022
Complete List of Authors:	Li, Yanlu; Ghent University, Center for Nano and Biophotonics Bellani, Claudio; KU Leuven, MTM Yebo, Nebiyu; Ghent University, Center for Nano and Biophotonics Dendooven, Jolien; Universiteit Gent, Solid State Sciences Seo, Jin Won; Katholieke Universiteit Leuven, MTM - Department of Materials Engineering Detavernier, Christophe; Universiteit Gent, Solid-state Sciences Baets, Roel; Universiteit Gent, INTEC Martens, Johan; KU Leuven Faculty of Bioscience Engineering, Center for Surface Chemistry and Catalysis: Characterisation and Application Team Pulinthanathu Sree, Sreeprasanth; K U Leuven, M2S Centre for Surface Chemistry and Catalysis

SCHOLARONE™ Manuscripts

Nanoporous Silica-Alumina Films Fabricated on Silicon Photonic Chips for Selective Ammonia Sensing

Yanlu Li ^{a,b}, Claudio Bellani ^c, Nebiyu Yebo ^{a,b}, Jolien Dendooven ^d, Jin Won Seo ^c, Christophe Detavernier ^d, Roel Baets ^{a,b}, Johan A. Martens ^e and Sreeprasanth Pulinthanathu Sree ^{c,e*}

- a. Photonics Research group, Ghent University-imec, Technologiepark-Zwijnaarde 126, 9052, Gent, Belgium
- b. Center for Nano- and Biophotonics, Ghent University, Technologiepark-Zwijnaarde 126, 9052 Ghent, Belgium
- c. Department of Materials Engineering, KU Leuven, 3001, Leuven, Belgium
- d. Dept. of Solid State Sciences, Ghent University, Krijgslaan 281/S1, Gent B-9000, Belgium
- e. Centre for Surface Chemistry and Catalysis, KU Leuven, Celestijnenlaan 200F, 3001, Leuven, Belgium

KEYWORDS. Nanoporous Silica films, Micro ring resonators, Atomic Layer Deposition, Selective gas Sensing, Ammonia Detection.

ABSTRACT: Surface-modified nanoporous silica films offer attractive features for analyte-specific gas detection applications. Here we demonstrate the integration of highly porous silica-alumina films on silicon nano-photonic chips and their performance in selective NH₃ detection. Prototype sensors with microporous as well as mesoporous silica films were assembled. The incorporation of aluminum in trace amount needed to generate acid sites was achieved during film deposition or using post-synthesis atomic layer deposition. Silicon photonic micro-ring resonators functionalized with both techniques demonstrated a selective response to NH₃ relative to CO₂. Furthermore, the response was rapid and reversible. The role of pre-adsorbed water vapor on the reversible nature of the sensor is also investigated. Experimental observations indicate that water vapor pre-adsorbed on the films leads to fast sensor recovery while maintaining selectivity towards NH₃. This could be attributed to the relatively less strong and still selective binding of NH₃ on protonated water molecules pre-adsorbed on the surface acid sites. The potential of modified nanoporous films for portable and low-cost NH₃ sensing on optical chips demonstrated here can be exploited in health care as well as industrial applications.

INTRODUCTION

Nanoporous thin films with accessible porosity are of interest to many applications including the development of adsorptive surfaces for optoelectronic sensor devices¹⁻⁷. Particularly, nanoporous silica and aluminosilicate films with transition metal oxide nanoparticles deposited on optical waveguide structures have been shown to be attractive for optical sensing^{8,9}. Adsorption of even trace amounts of gaseous or liquid analytes alters the refractive index or optical absorption of nanoporous coatings, hence, making these planar optical systems suitable for sensing^{10,1112}. A large surface area and accessible porosity in the sensor film can lead to high sensitivity to guest molecules. In addition, modification of nanoporous silica surfaces by introducing functional groups can enable analyte-specific detection which is needed in the majority of environmental, industrial, and medical applications. Chemical functionality can be introduced either during synthesis or via post-synthesis modification¹³. Atomic layer

deposition (ALD) is a self-limiting thin film growth technique where a substrate is subjected to sequential exposures of chemical precursors and has been demonstrated to be an efficient post-synthesis functionalization technique for mesoporous films^{14,15}.

Among other optical technologies, ultra-compact and CMOS-compatible silicon nanophotonic planar sensors are emerging as promising technology for highly portable and low-cost sensing applications^{10,1116–20}. Using CMOS fabrication technology, inexpensive mass fabrication along with seamless integration in a portable footprint can be achieved. Moreover, these miniature sensors can easily be multiplexed for parallel detection of gas mixtures on a photonic chip.

One of the silicon photonic components promising for gas sensing applications is a micro-ring resonator (MRR). MRRs are resonant structures with a typical diameter of only several microns on an optical chip. The resonant behavior of these structures shows a high sensitivity to physical

changes in the surrounding, making them attractive as miniature sensors \$^{10,1116-20}\$. MRRs offer inherent multiplexing features for straightforward sensor array implementation. An optical microring resonator is a ring waveguide cavity coupled to access waveguides. Light is coupled in and out of the ring waveguide using the straight access waveguides. An MRR supports circulating resonant waveguide modes. The electric field of these guided modes extends to the surface of the ring allowing evanescent field interaction with the outside environment. Particularly, high index contrast waveguide structures such as silicon-oninsulator (SOI) MRRs presented here are characterized

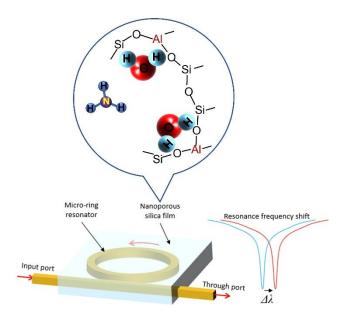


Figure 1. Alumino slicate functionalized microring resonator (MRR) in ammonia sensing and effective index change induced resonance shifts.

by strong evanescent field localized at the waveguide surfaces. As a result, high sensitivity to variations in the surrounding refractive index can be achieved. For each MRR, there is a series of resonance wavelengths. Light with these wavelengths is enhanced within the ring which leads to enhanced absorption or scattering relative to non-resonant wavelengths. Therefore, a transmission dip can be found in the through-port of the MRR (Fig. 1). The corresponding resonance shift $\Delta\lambda$ in the microring resonance wavelength can be estimated by Eqn. 1

$$\frac{\Delta \lambda}{\lambda} = \frac{\Delta n_{eff}}{n_g} \tag{1}$$

where λ , n_{eff} , and n_g represent the resonance wavelength, the effective index, and the group index of the guided mode, respectively. The resonance shift can be spectrally quantified as a measure of the concentration of a given analyte being detected. Figure 1 sketches a surface-functionalized MRR and resonance shift due to changes in the surroundings.

Adsorption of NH₃ molecules onto the surface of these nanoporous films leads to an effective index change of the

coated ring resonator. The effective index change can be attributed to a combination of physical mechanisms including pore-filling, adsorption, heat, and change in carrier density of the film^{11,16,21,22}. An increased density of guest molecules in the porous films can change the film refractive index. On the other hand, since adsorption is an exothermic process, the resulting heat of adsorption can alter the effective index via the thermo-optic effect^{10,21}. Moreover, charge exchange between surface sites and guest molecules can modify the carrier density and hence the film refractive index²². The predominant mechanism behind the capacity of these aluminosilicate materials for selective uptake of NH3 has been explained by studying a powder counterpart of the material using advanced NMR techniques²³. It was evident from the study that a majority of ammonia is blended with the hydrogen-bonded water network in the micropores of the aluminosilicate as indicated in fig 1.

There exists different materials which can sense ammonia, but there are challenges associated to them while in application. For example metal oxide semiconductors²⁴⁻ ²⁷are highly sensitive and cheap but their high operating temperature, water sensitivity, long recovery period and poor selectivity in complex gas mixtures are some drawbacks in using them for ammonia sensing. Conducting polymers^{24,28-30} are highly selective and fast in ammonia sensing but their low reproducibility and low stability are issues. While non conducting polymers^{24,31} can operate at low temperatures, their poor stability and selectivity makes them less attractive. Metal Organic Frameworks, MOFs^{32,33} are highly selective and sensitive but demand of crystalline structure to exhibit sensitivity and water sensitive nature of many MOFs are challenges in using them for ammonia sensing. Carbon nanotubes^{28,34-38} and Graphene^{33,39,40} pocess high sensitivity and can operate at low temperatures but their costs, low recovery times and difficulties in transferring it to the desired form are challenges. Aluminosilicates especially in the form of thin films are more interesting as they are stable, highly sensitive, reproducible, cheap and has got high adsorption capacity due to high surface area. Note that the MRR is not the only sensing structure to detect the refractive index change of microporous coating layers. Other photonic structures, e.g. Mach Zehnder interferometers (MZI) and various other whispering gallery mode (WGM) sensors 41, are also often used. One example is a silicon-nitride MZI covered with a mesoporous silica layer, which has demonstrated ppb level sensitivities to acetone, isopropyl alcohol, and ethanol¹². The other example is different kinds of WGM sensors, which take advantage of the WGM formed by the outer boundary of a circular cavity. The cavities can be microtoroid, microdisk, microsphere, microbottle, and microbubble⁴¹. In many cases, MRRs are considered as WGM sensors. But in this paper, the name "WGM sensor" indicates those WGM sensors which are different from the MRRs. Many reported WGM sensors have much smaller optical losses than those in MRRs. One reason is that the optical fields in a (single-TEmode) MRR sensor experience side-wall scattering from both sides of the waveguide, while that scattering effect only happens on one side of a WGM sensor. Additionally, most reported WGM sensors are thermally treated (e.g., scale surface roughness at the boundary of the WGM sensor. As a result, most reported WGM sensors have very low optical losses and very high quality-factors (Q-factors), e.g., 100 million^{42,43}. In comparison, untreated MRRs usually have O factors between 10⁴ and 10⁶ 11,44,45. A WGM based ammonia sensor having high sensitivity with parts-pertrillion level limit of detection has been reported recently⁴⁶ But the disadvantage of WGM sensors is the high fabrication cost associated with the special surface treatments. Though MRR sensors generally have worse Q factors, their sensor sensitivities (resonance wavelength shift per refractive index change of the cladding material) can be better since they can interact with the sensing material from both sides⁴⁷. What's more, the choice of the Q factor also depends on the wavelength resolution of the tunable laser source. The laser wavelength resolution in our system is 10 pm, which fits well with the full-width halfmaximum (WHFM) of the MRR resonances (around 110 pm). This resolution is not good enough to detect the resonance of a high-Q WGM sensor.

laser reflow⁴²) in the fabrication process to enable an atom-

Despite the considerable benefits ultra-compact optical sensors can offer, progress in the integration of highly sensitive and analyte-specific materials is yet to be made to fully exploit their potential. The authors previously demonstrated the feasibility of integrating aluminosilicate films with MRRs and selective detection of ammonia 11 . In the present study, we investigate the sensitivity limits, and the interference of other gases (e.g., $\rm CO_2$) and molecules (e.g., water and acetone). The performance repeatability of the sensor is also studied concerning applications where the sensor is exposed continuously to ambient conditions.

For creating Al functionalized coating over MRRs two approaches are used. The first technique involves the incorporation of aluminum during the synthesis of microporous silica films whereas, in the second approach, spacious mesoporous silica films are initially prepared on the sensor chips, and afterwards functionalized by atomic layer deposition of aluminum. Al content in these films imparts acidic surface sites favorable for $\rm NH_3$ adsorption. We achieved selective, fast, reversible, and durable ammonia detection using nanophotonic chips coated with both types of aluminosilicate films

EXPERIMENTAL

Fabrication of MRRs: The MRR in SOI used as the substrate for casting nanoporous films had a radius of 5 μm, and was designed for operation in the telecom wavelength band near 1550 nm. The bus and ring waveguides are 220 nm high and 450 nm wide in dimension. For coupling light in and out of the rings, grating couplers are connected to the bus waveguides through adiabatic tapers. The distance between the two grating couplers is ca. 3.5 mm. This long separation is chosen to reduce the amount of optical power coupled from the input port to the output ports directly via the bottom of the chip. An array of MRR channels is designed in such a way that the input and output grating couplers are placed close to each other so that they can be illuminated at the same time when the light source is placed at a certain distance away from the chip (Fig.2). In practice, two MRRs were placed on each bus waveguide to evaluate the Vernier effect. However, in this paper, we still use the resonance shift of a single ring for sensing. The silicon photonic chips are fabricated using standard CMOS fabrication tools. The standard fabrication process starts with wafer-scale photo-resist patterning of silicon-oninsulator substrates with 193 nm deep-UV lithography 48 . After this step, nano-photonic structures are formed by dry etching the top 220 nm thick silicon layer. The SOI substrate consisted of a 2 μ m thick buried oxide layer sandwiched between a top silicon layer and a bottom silicon substrate.

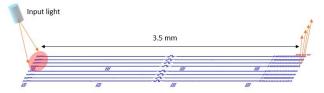


Figure 2. A schematic of the MRR biosensors and the method to couple light into the sensors

Microporous aluminosilicate film deposition on MRR:

The preparation of microporous films starts with the synthesis of Clear Solution containing silica nano slabs doped with Al. To introduce Al, Al powder was dissolved in an aqueous tetrapropylammonium hydroxide (TPAOH) aqueous solution. Tetraethylorthosilicate (TEOS) was added and hydrolyzed, and subsequently, water was added. The final molar ratio of TEOS: Al : TPAOH : $\rm H_2O$ was 25: 0.25: 9: 400. An amount of 2 ml of the resulting clear solution was diluted with 8 ml absolute ethanol and spincoated on the SOI samples. Afterwards, the films on the silicon MRRs were kept in a hydration chamber with constant humidity (75%) for a day and then dried at 60°C followed by calcination at 350°C with a heating ramp of 0.5 °C /min.

Mesoporous silica film deposition on MRR: The synthesis of mesoporous silica thin films was adapted from⁴⁹. In a typical preparation, initially a colloidal suspension of silica nanoslabs called "Clear Solution" was prepared by hydrolysis of TEOS in aqueous TPAOH solution followed by addition of water. After adding H₂O, the clear solution was kept on stirring for 24 h. The molar ratio of TEOS: TPAOH: H₂O was 25: 9: 400. 4.5 g of this suspension was mixed with 2.25 g of 5 M HCl and then combined with 6 g of 10 % (wt.) aqueous Pluronic P123 triblock copolymer (E020P070 EO20) solution which was already acidified using 2 g of 5 M HCl. 2 ml of the resulting suspension of the nanoslabs and the triblock copolymer was diluted with 8 ml absolute ethanol and spin-coated on the SOI samples. Then the films were hydrothermally annealed at 90°C for ca. 60 h by suspending them in an autoclave filled with water at the bottom. After drying at 60°C, the films were calcined at 350°C using a slow heating ramp of 0.5°C/min.

Al-ALD to the mesoporous silica films on Si MRRs: Al ALD into the mesoporous silica films integrated onto the Si MRRs was done in a home-built ALD reactor. The chemical precursors used in ALD were trimethylaluminum (TMA) and water. For the sensors studied in this work, 10 ALD cycles were performed where each cycle involves two subsequent self-terminating half-reactions. In the first half-

reaction, the sample is exposed to TMA [Al(CH₃)₃, 97% purity, Sigma-Aldrich] for 10 s, followed by a 15 s evacuation of the reaction chamber. The second half-reaction consists of a 10 s water pulse, again followed by a 15 s evacuation. The depositions were done at a temperature of 200 °C at a pressure of TMA and $\rm H_2O$ vapor of 0.3 Pa.

Ellipsometric porosimetry (EP): EP on the calcined film was carried out in a vacuum chamber to which the spectroscopic ellipsometer (Sentech SE801, 350–850 nm wavelength) was mounted and a system for dosing adsorbates was connected. The probe molecule used was toluene. For the recording of the adsorption-desorption isotherms, the adsorbate pressure was slowly increased until the saturation pressure was reached followed by slow evacuation of the chamber. The ellipsometric angles Ψ and Δ over the whole spectral range of 350-850 nm, the pressure, and the time were continuously recorded. These data were used for the calculation of porosity and pore size distribution as described in literature 49,50 .

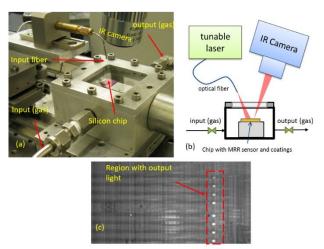


Figure 3. (a) Measurement setup to test the sensitivity of coated MRRs to gases. (b) The schematic of the setup. (3) The IR image of the output grating couplers, in which the bright spots on the grating couplers only shine when the input light is coupled into the MRR via the input grating couplers

High Resolution Transmission electron microscopy (HR TEM) was performed with a probe-corrected transmission electron microscope (ARM200F cold-FEG, JEOL) operated at an acceleration voltage of 200 kV. The samples were prepared by dispersing the patches of film scrapped off from a silicon wafer in 2-propanol and placing a few drops of the suspension onto the copper TEM grids covered with a lacey carbon film (Pacific Grid Tech).

HR-SEM was performed on a Nova NanoSEM450 (FEI) scanning electron microscope. The films casted on silicon wafers were mounted on Al stubs using carbon stickers and observed without any additional coating, using low voltages and a concentric backscattered (CBS) detector in the immersion lens mode.

Sensing measurement: The sensitivity experiments were done in an optical setup equipped with a small gas chamber, a tunable laser, and an infrared (IR) camera (Fig. 3a). The sensor chip is kept in the chamber which is sealed on top by

a glass window. The glass window allows vertical light coupling in and out of the sensor chip via grating couplers. At the input side, a single-mode fiber is used to couple light from the tunable laser (Santec TSL-510) with an optical power of 2 mW and wavelength tuning resolution of 10 pm. The output light beams from the sensor chip are collected by an IR camera (Xenics-Xeva) while the laser is tuned across the resonance wavelength with a range of 5 nm (Fig. 3.b). Thanks to the distance between the input fiber and the input grating couplers, light can be coupled to several waveguides with different MRRs simultaneously. The transmission signals of these MRRs can then be picked by the IR camera from the corresponding output grating couplers. (Fig. 3.c). The wavelength data from the tunable laser source and the intensity data from the camera are sent to a data acquisition card simultaneously. Therefore, we can retrieve the output spectra from the MRRs at each sweep cycle (around 9 s).

The measured full-width half-maximum (FWHM) values of the transmission of the MRRs coated with microporous film is around 110±10 pm, which corresponds to a Q-factor of around 13,900 at 1530 nm. The measured free spectral range (FSR) is around 13.4 nm, which is much larger than the wavelength tuning range in the measurement (5 nm). The extinction ratios of the coated MRRs are between 4.5 dB and 11 dB. This deviation is mainly associated to the different local properties of the deposited film on different MRRs. The optical properties of the MRRs will change after the coating, which is however not studied in this paper.

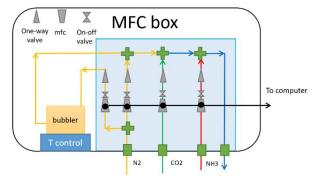


Figure 4. Schematic of the gas control system based on MFCs $\,$

Streams of NH $_3$ gas from storage cylinders are diluted with pure N $_2$ by using mass flow controllers (MFCs) from Bronkhorst and introduced at different concentration levels into the test chamber. While changing the gas concentration, the total flow rate is kept constant at 100 L/h or 200 L/h. Since the target application is breath analysis, the responsivities to NH $_3$ are measured when CO $_2$ and H $_2$ O are also present in the same gas. The H $_2$ O is added by sending a fraction of N $_2$ flow through a bubbler filled with water. A schematic diagram of the gas control system is shown in Fig. 4.

RESULTS AND DISCUSSION

The calcined microporous aluminosilicate films on the silicon MRRs were ca. 100 nm thick. The toluene adsorption isotherm determined using EP (Fig. 5) shows very strong toluene uptake at low relative pressure, due to strong adsorption in micropores. The absence of hysteresis

revealed that the films were purely microporous. The pore size distribution calculated from the adsorption branch was centered at 1.2 nm. The microporous films with 100 nm thickness pocessed a low refractive index of 1.2 and a porosity of ca. 45% which is quite high for a microporous film specimen. Similar measurements on a mesoporous film present an isotherm with a clear hysteresis loop between the adsorption and desorption branches in the P/P° range 0.4-0.8 revealing the presence of mesopores. The porosity was ca. 70% and the distribution of pore diameters centered around 7 nm (Fig 6). The high porosity reasons the very low refractive index of 1.09 for these films. The film thickness was around 120nm. HR SEM of microporous films casted on a plain silicon wafer presented very smooth surface where as in case of mesoporous films randomly ordered pores can be visualized from the surface itself (Fig. 7 a, b) HR TEM performed on patches of films scrapped off from the thin film made on a silicon wafer revealed similar random porous network (light grey and white areas.) As expected microporous film are more denser than mesoporous ones (fig 7 c, d)

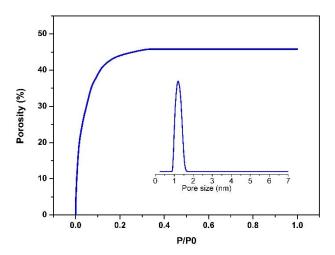


Figure 5. Adsorption isotherm and corresponding micropore size distribution (inset) measured by EP on a calcined microporous silica-alumina film similar to one coated over the MRR.

Sensitivity of microporous layers on MRRs: responsivities of the MRRs coated with the microporous aluminosilicate films to different NH₃ concentrations have been measured. The NH₃ concentrations are set as 100 ppb, 250 ppb, 500 ppb, and 1.25 ppm by the MFCs while the flow rate is kept at 200 L/h. The humidity of the gas is set to 80% at 20°C to get a similar condition as the respiratory gas. For each test period, the gas with the desired NH₃ concentration is sent to the chamber for 5 min. Then NH₃ flow is stopped. Meanwhile, the sample is blown by pure N₂ for another 10 min to drive out the residual gas. The gas flows with the same NH₃ concentration are repeated three times before changing the NH₃ concentration. During the measurement, the tunable laser repeats the sweep of its output wavelength while the IR camera is reading the corresponding output spectrum from the grating couplers. Each sweeping period is around 9 s. Before the entire measurement is started, the sample is baked on a hotplate at 150 °C. The baking process

can drive any residual gas out of the pores and hence regenerate the MRRs.

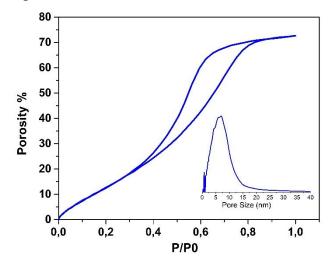


Figure 6. Toluene adsorption isotherms measured by Ellipsometric Porosimetry (EP) and mesopore size distribution (inset) of a calcined silica film which is representative of the mesoporous silica coating over the MRR prepared for further functionalization with Al ALD

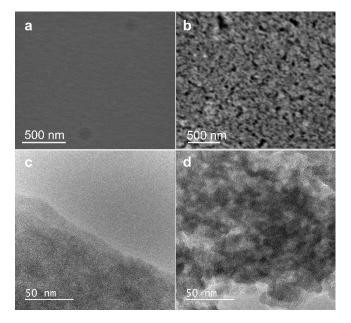


Figure 7. (a, b)HR SEM and (c,d) HR TEM of microporous and mesoporous films respectively

Four MRRs from four adjacent grating couplers were measured. The relative wavelength shifts of the MRR resonance wavelengths are calculated from the obtained spectra. One example of the output spectra is shown in Fig. 8. It can be seen that the resonance frequencies of these transmission spectra can be distinguished. However, their extinction ratios (ERs) (between 4.5 dB and 11 dB) and Q factors (around 13,900) are not very high. One reason is that the MRR waveguide is designed in such a way that a large portion of the optical field is outside of the waveguide

core to sense the adsorbed gas. This design improves the sensitivity of the MRR, but also increases the scattering loss of light and hence reduces the Q-factors and the ERs. There are relatively strong ripples in the spectrum, which are caused by another cavity in the system. Based on the free spectrum range of the ripples, it could be inferred that they are originating from the interference between the grating coupler and the bottom of the PIC (thickness of the PIC is ca. 750 $\,\mu m$). These ripples can also shift as a result of temperature change, which will hence impact the resolution of the retrieved resonance wavelengths.

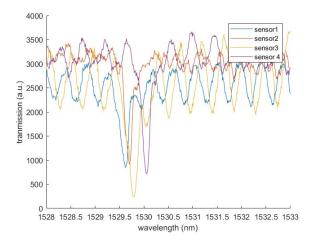


Figure 8. Through port spectra for the four MRRs, showing the resonance dips.

To obtain the resonance wavelength with relatively good accuracy, we first obtain the minimal value of the transmission dip λ_{min} . Then a mass-center algorithm is applied to the range of $[\lambda_{min}$ - 15 pm, λ_{min} + 15 pm], while the spectra outside of this range are all set to zero. The mass center of the transmission dip is obtained by calculating the value of $\lambda_{mc}(t) = \sum T_r(\lambda,t)^4 \cdot \lambda/\sum T_r(\lambda,t)^4$, where $T_r(\lambda,t) = T_{trans}(\lambda,t) \cdot T_{trans,max}(t)$, $T_{trans}(\lambda,t)$ is the transmission at wavelength λ , and $T_{trans,max}(t)$ is the maximal transmission value in the entire spectrum. The power of the fourth was used in the calculation to ensure the contribution of the dip has the greatest impact on the calculated value. Then the change of the "mass center" $\lambda_{mc}(t)$ is assumed to equal the shifts of the resonance wavelength.

The resonance wavelength shifts of the four MRRs as a function of time are shown in Fig.9. It can be seen that the wavelength responses of sensor 2, 3, and 4 are very similar, while sensor 1 is different from the others. The deviation of sensor 1 from the other sensors can be explained by the lower ER of the corresponding resonance dip and the higher fringes in the transmission spectrum (Fig 8).

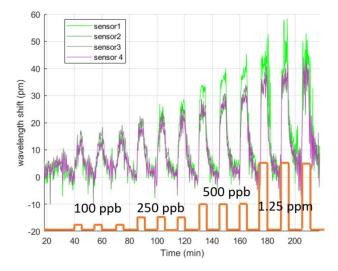


Figure 9. Resonance wavelength shifts as a function of time for four adjacent MRR sensors. The corresponding $NH_{\rm 3}$ concentrations set by the MFC are also plotted in the same figure.

In the experiments, no temperature controller is used in the setup to avoid the small temperature variations induced by a temperature controller. As a result, the wavelength will drift slowly due to the change of the temperature, but this effect can be removed in software. In these experiments, the slow wavelength drift is retrieved from a number of data points that should be very similar when there is no tempeature drift. In practice the data points just before each NH₃ pulses are used. These data are then fitted to a 4thdegree polynomial, which are then subtracted from the original data to obtain the data shown in Fig. 9. The order of 4th degree is an empirical value that ensures the best polynomial fitting to the measured data. Another option is to use a reference temperature sensor (e.g. an MRR without any coating), which however requires extra processes (such as photolithography and lift-off) that may change the performance of the nanoporous coatings by leaving residue materials. Therefore, we didn't make reference temperature sensors for these measurements.

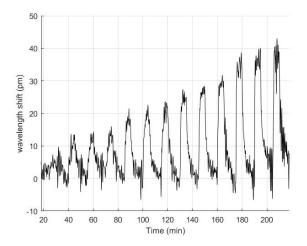


Figure 10. Averaged resonance wavelength shifts as a function of time with a relative humidity of 80% at 20 $^{\circ}\text{C}.$

As mentioned, in total three test pulses for each NH_3 concentration were used, which can also be averaged. The averaged response curves for the tested NH_3 concentrations are shown in fig. 11. It can be seen that the rise times are different for different NH_3 concentrations. A higher NH_3 concentration corresponds to a faster rise time. For 1.25 ppm concentration, it takes only around 30 seconds to reach 95% of the peak value. For 100 ppb concentration, the rise time is ca. 4 min. The average recovery time from the maximal resonance shift to 5% of the maximal resonance shift for these samples is a bit longer than 8 min, which is longer than our previous demonstration 11 . The main reason is that the NH_3 concentrations demonstrated in this paper are much smaller. But it is already much faster than other techniques 51,52 .

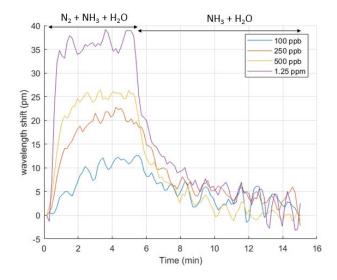


Figure 11. The time responses of the resonance wavelength of the MRRs as functions of time for different $\rm NH_3$ concentrations with a relative humidity of 80% at 20 $^{\circ}\text{C}$

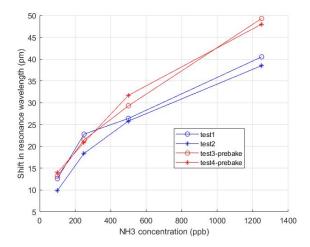


Figure 12. Resonance wavelength responses to different NH_3 concentrations. The blue curves are two repeated measurements on one MRR chip, while the red curves stand for the responsivities of the MRR chips with a prebaking step. The relative humidity is 80% at 20 °C.

It can be seen that the MRR resonators with microporous layers are good enough to detect ppb levels of NH3 with relative humidity (RH) of 80%. The response can be detected within 5 min. The wavelength shift response for 100 ppb NH₃ concentration is greater than 10 pm. The noise amplitude is estimated by calculating the difference between 10% and 90% percentiles of the resonance shift values in the last three minutes in each period, which is around 6 pm. The four sensors experience correlated noise which may be induced by temperature change or flow rate change (due to the existence of the bubbler that is used for controlling the RH). Therefore, averaging these four sensors will not reduce the major noise. However, averaging over the 3 successive pulses in one measurement can suppress the noise, and make the 10%-90% amplitude of the noise go down to ca. 3.5 pm. For the NH₃ pulse with 1.25 ppm concentration, the response is between 35 pm and 40 pm. responses were measured twice, and the corresponding response curves are shown together in Fig. 12. It can be seen that the responsivity deviations between two different measurements are usually less than 5 pm. In these measurements, the samples are cleaned and regenerated on a hotplate in the open air. After regeneration, the sample is transported to the measurement chamber, during which some H₂O or other gases may be absorbed into the microporous layer. As a result, the initial status of the MRRs can be different from time to time. A prebaking step inside the chamber may help to further clean the microporous layer. We tested the responsivities of the MRRs to NH₃ with the prebaking steps. The prebake temperature was set at 40°C and the prebaking time was 10 min. The corresponding NH₃ responses are also shown in Fig. 12. It is seen that the NH₃ responses were generally higher than those without pre-baking steps, and their relative deviations were also smaller (< 3 pm).

We noticed that the MRRs are very sensitive to H_2O . The measured responsivity to different RH (no NH_3) at 20 °C is shown in Fig. 13. It can be seen that the response to RH

change is very strong. Therefore, it is important to control the relative humidity for NH₃ sensing.

The responsivities for different NH_3 concentrations in dry conditions are slightly higher than those in the condition with RH = 80%. The responsivity curves to NH_3 pulses at a

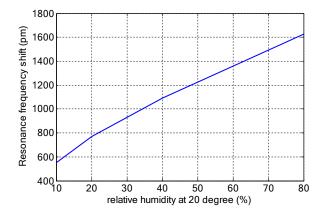


Figure 13. Resonance wavelength shifts as a function of relative humidity at 20 °C. The measurements were done in conditions without any NH_3 gas.

dry conditions are shown in Fig. 14. In these measurements, we didn't introduce any $\rm H_2O$ in the gas. However, there was still a very small amount of $\rm H_2O$ introduced from the tube system during the measurements. Therefore, the term "very low relative humidity" is used to describe this condition. Note that the used NH $_3$ concentrations for the "very low relative humidity" are different from those used with RH = 80%. That's because different mass controllers were used for these two cases. It is also found that the curves of the responses in the dry condition have weaker fluctuations compared to the measured signals in the RH = 80% condition. That may be related to not using the bubbler, which may cause an unsteady flow rate and varying $\rm H_2O$ concentrations.

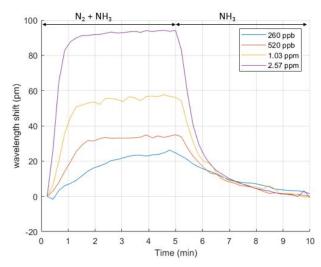


Figure 14. The time responses of the resonance wavelength of the MRRs as a function of time for different NH_3 concentrations with a very low relative humidity at $20\ ^\circ\text{C}$

In normal breath, there is also a relatively large concentration of CO_2 , which can impact the NH_3

responsivity. We tested the MRR responses to different NH_3 concentrations in a condition with 0.8% of CO_2 (RH = 80%). It was found that the response of the MRR to 250 ppb NH_3 is around 22.8 pm, while to 500 ppb NH_3 the response was 27 pm. These values are within the error range of the NH_3 responses when no CO_2 exists. After the CO_2 concentration was changed from 0 to 1.6%, the MRR's response to NH_3 was not clearly changed. Therefore, we can conclude that the presence of CO_2 doesn't impact the measurement of NH_3 at the condition of RH = 80%. However, in a drier condition, CO_2 can also introduce a relatively large shift in the MRR sensor. For example, 1% CO_2 can cause a shift of 60-70 pm. But when H_2O is present (RH = 80%), the impact of CO_2 on MRR will be strongly reduced.

Additionally, the response of MRRs to NH_3 with the presence of acetone was also tested. With 100 ppm acetone, the response of NH_3 does not change significantly from the case without acetone. So, it can be understood that the presence of acetone doesn't impact the MRR's response to NH_3 . However, the change in acetone concentration does lead to a change in the MRR resonance, which is shown in Fig. 15. It is also found that when no H_2O is present, the response to acetone is much stronger.

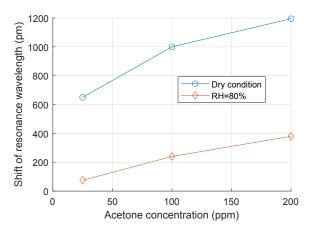


Figure 15. Resonance wavelength responses to different acetone concentrations at different relative humidity levels (80% and very low) at 20 $^{\circ}\text{C}$

Besides the microporous layer, the mesoporous layer which has relatively larger pore sizes was also tested. By introducing acidic functional material (Al) into the mesoporous material, it can also be used for sensing NH $_3$ gas. One example is shown in Fig. 16. The mesoporous layer has a pore size of around 7 nm. They are functionalized with Al $_2$ O $_3$ by 10-cycle ALD. The relative humidity of the gas in these measurements is 80%. The flow rate was set as 100 L/h to reach a higher NH $_3$ concentration. It turned out that the mesoporous layers also have a ppb-level LOD. However, since the measurements were done with different flow rates, we cannot strictly compare the sensitivities of mesoporous layers with Al-ALD and micro-porous layers.

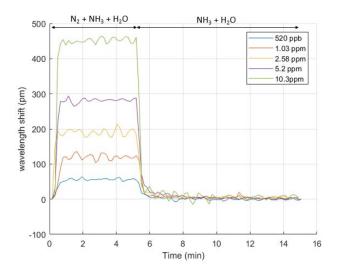


Figure 16. Resonance wavelength shifts of MRRs coated with mesoporous layer (pore size = 7nm, 10-cycle Al-ALD) for different NH₃ concentrations

CONCLUSIONS

Functional nanoporous films offer attractive features for selective and highly sensitive gas detection on nano/microphotonic chips. Selective, fast and reversible, and reproducible NH3 detection is demonstrated using acidic nanoporous silica-alumina films on silicon microring resonators. Both microporous layers and mesoporous layers with Al-ALD demonstrated ppb level detection. A key mechanism behind reversible NH3 sensitivity observed in our sensors is experimentally investigated. Sensitive, fast, nano-porous film-coated selective demonstrated here open new opportunities for portable and real-time gas sensing in medical and industrial applications.

AUTHOR INFORMATION

Corresponding Author

* Sreeprasanth Pulinthanathu Sree, sree.psree@kuleuven.be Centre for Surface Chemistry and Catalysis, KU Leuven, Celestijnenlaan 200F, 3001, Leuven,

Author Contributions

The manuscript was written through the contributions of all authors.

ACKNOWLEDGMENT

YL, RB acknowledge the Industrieel Onderzoeksfonds Hoofdfinanciering (IOF) funding project BREAZE, JAM, RB, SPS, NAY, acknowledge the Flemish government for long-term structural funding (Methusalem). These authors also acknowledge the European Research Council (ERC)- Inspectra project of RB for funding. CD acknowledges the Fonds voor Wetenschappelijke Onderzoek Vlaanderen (FWO) and the European Research Council (ERC) for funding. CD acknowledges the FWO-Vlaanderen for funding (project nr. G077012).

REFERENCES

- (1) Cortial, G.; Siutkowski, M.; Goettmann, F.; Moores, A.; Boissière, C.; Grosso, D.; Le Floch, P.; Sanchez, C. Metallic Nanoparticles Hosted in Mesoporous Oxide Thin Films for Catalytic Applications. *Small* **2006**, *2* (8–9), 1042–1045. https://doi.org/10.1002/smll.200600154.
- (2) Kang, T.; Oh, S.; Hong, S.; Moon, J.; Yi, J. Mesoporous Silica Thin Films as a Spatially Extended Probe of Interfacial Electric Fields for Amplified Signal Transduction in Surface Plasmon Resonance Spectroscopy. Chem. Commun. 2006, No. 28, 2998. https://doi.org/10.1039/b600140h.
- (3) Walcarius, A.; Kuhn, A. Ordered Porous Thin Films in Electrochemical Analysis. *TrAC Trends Anal. Chem.* 2008, 27 (7), 593–603. https://doi.org/10.1016/j.trac.2008.03.011.
- (4) Monton, M. R. N.; Forsberg, E. M.; Brennan, J. D. Tailoring Sol-Gel-Derived Silica Materials for Optical Biosensing. *Chem. Mater.* 2011, 24 (5), 796–811. https://doi.org/10.1021/cm202798e.
- (5) Konjhodzic, D.; Schröter, S.; Marlow, F. Ultra-Low Refractive Index Mesoporous Substrates for Waveguide Structures. Phys. status solidi 2007, 204 (11), 3676–3688. https://doi.org/10.1002/pssa.200776405.
- (6) Kataoka, S.; Endo, A.; Harada, A.; Inagi, Y.; Ohmori, T. Characterization of Mesoporous Catalyst Supports on Microreactor Walls. Appl. Catal. A Gen. 2008, 342 (1–2), 107– 112. https://doi.org/10.1016/j.apcata.2008.03.011.
- (7) Angelos, S.; Liong, M.; Choi, E.; Zink, J. I. Mesoporous Silicate Materials as Substrates for Molecular Machines and Drug Delivery. *Chem. Eng. J.* **2008**, *137* (1), 4–13. https://doi.org/10.1016/j.cej.2007.07.074.
- (8) Martucci, A.; Buso, D.; Guglielmi, M.; Zbroniec, L.; Koshizaki, N.; Post, M. Optical Gas Sensing Properties of Silica Film Doped with Cobalt Oxide Nanocrystals. J. Sol-Gel Sci. Technol. 2004, 32 (1–3), 243–246. https://doi.org/10.1007/s10971-004-5795-3.
- (9) Tang, X.; Provenzano, J.; Xu, Z.; Dong, J.; Duan, H.; Xiao, H. Acidic ZSM-5 Zeolite-Coated Long Period Fiber Grating for Optical Sensing of Ammonia. J. Mater. Chem. 2011, 21 (1), 181–186. https://doi.org/10.1039/c0jm02523b.
- Yebo, N. A.; Lommens, P.; Hens, Z.; Baets, R. An Integrated Optic Ethanol Vapor Sensor Based on a Silicon-on-Insulator Microring Resonator Coated with a Porous ZnO Film. Opt. Express 2010, 18 (11), 11859. https://doi.org/10.1364/oe.18.011859.
- (11) Yebo, N. A.; Sree, S. P.; Levrau, E.; Detavernier, C.; Hens, Z.; Martens, J. A.; Baets, R. Selective and Reversible Ammonia Gas Detection with Nanoporous Film Functionalized Silicon Photonic Micro-Ring Resonator. Opt. Express 2012, 20 (11), 11855. https://doi.org/10.1364/oe.20.011855.
- (12) Antonacci, G.; Goyvaerts, J.; Zhao, H.; Baumgartner, B.; Lendl, B.; Baets, R. Ultra-Sensitive Refractive Index Gas Sensor with Functionalized Silicon Nitride Photonic Circuits. *APL Photonics* **2020**, *5* (8), 81301. https://doi.org/10.1063/5.0013577.
- (13) Linares, N.; Serrano, E.; Rico, M.; Mariana Balu, A.; Losada, E.; Luque, R.; García-Martínez, J. Incorporation of Chemical Functionalities in the Framework of Mesoporous Silica. *Chem. Commun.* **2011**, 47 (32), 9024. https://doi.org/10.1039/c1cc11016k.
- (14) Detavernier, C.; Dendooven, J.; Pulinthanathu Sree, S.; Ludwig, K. F.; Martens, J. A. Tailoring Nanoporous Materials by Atomic Layer Deposition. *Chem. Soc. Rev.* **2011**, *40* (11), 5242. https://doi.org/10.1039/c1cs15091j.
- (15) Sree, S. P.; Dendooven, J.; Korányi, T. I.; Vanbutsele, G.; Houthoofd, K.; Deduytsche, D.; Detavernier, C.; Martens, J. A. Aluminium Atomic Layer Deposition Applied to Mesoporous Zeolites for Acid Catalytic Activity Enhancement. *Catal. Sci. & Eamp; Technol.* 2011, 1 (2), 218. https://doi.org/10.1039/c0cy00056f.
- (16) Yebo, N. A.; Taillaert, D.; Roels, J.; Lahem, D.; Debliquy, M.; Van Thourhout, D.; Baets, R. Silicon-on-Insulator (SOI) Ring Resonator-Based Integrated Optical Hydrogen Sensor. *IEEE*

- Photonics Technol. Lett. 2009, 21 (14), 960-962. https://doi.org/10.1109/lpt.2009.2021073.
- (17)Jokerst, N.; Royal, M.; Palit, S.; Luan, L.; Dhar, S.; Tyler, T. Chip Scale Integrated Microresonator Sensing Systems. J. 2009, **Biophotonics** 2 212-226. https://doi.org/10.1002/jbio.200910010.
- (18)Sun, Y.; Fan, X. Analysis of Ring Resonators for Chemical Vapor Sensor Development. Opt. Express 2008, 16 (14), 10254. https://doi.org/10.1364/oe.16.010254.
- (19)Nitkowski, A.; Chen, L.; Lipson, M. Cavity-Enhanced on-Chip Absorption Spectroscopy Using Microring Resonators. Opt. 2008, **Express** 16 (16),11930. https://doi.org/10.1364/oe.16.011930.
- (20)Robinson, J. T.; Chen, L.; Lipson, M. On-Chip Gas Detection in Silicon Optical Microcavities. Opt. Express 2008, 16 (6), 4296. https://doi.org/10.1364/oe.16.004296.
- (21)Felix, S. P.; Savill-Jowitt, C.; Brown, D. R. Base Adsorption Calorimetry for Characterising Surface Acidity: A Comparison between Pulse Flow and Conventional "Static" Techniques. 2005, Thermochim. Acta 433 (1-2),https://doi.org/10.1016/j.tca.2005.02.012.
- (22)Gomri, S.; Seguin, J.-L.; Guerin, J.; Aguir, K. A Mobility and Free Carriers Density Fluctuations Based Model of Adsorption-Desorption Noise in Gas Sensor. J. Phys. D. Appl. Phys. 2008, 65501. https://doi.org/10.1088/0022-3727/41/6/065501.
- (23)Vallaey, B.; Radhakrishnan, S.; Heylen, S.; Chandran, C. V.; Taulelle, F.; Breynaert, E.; Martens, J. A. Reversible Room Temperature Ammonia Gas Absorption in Pore Water of Microporous Silica-Alumina for Sensing Applications. Phys. Chem. Chem. Phys. 2018, 20 (19), 13528-13536. https://doi.org/10.1039/c8cp01586d.
- (24)Liu, X.; Cheng, S.; Liu, H.; Hu, S.; Zhang, D.; Ning, H. A Survey on Gas Sensing Technology. Sensors (Basel). 2012, 12 (7), 9635-9665. https://doi.org/10.3390/s120709635.
- (25)Timmer, B.; Olthuis, W.; Berg, A. van den. Ammonia Sensors and Their Applications—a Review. Sensors Actuators B Chem. 107 (2). 666-677. https://doi.org/10.1016/j.snb.2004.11.054.
- (26)Chang, S. C.; Stetter, J. R.; Cha, C. S. Amperometric Gas Sensors. Talanta 1993. 461-477. https://doi.org/10.1016/0039-9140(93)80002-9.
- (27)Moseley, P. T. Progress in the Development of Semiconducting Metal Oxide Gas Sensors: A Review. Meas. Sci. 2017, https://doi.org/10.1088/1361-6501/aa7443.
- (28)Abdulla, S.; Mathew, T. L.; Pullithadathil, B. Highly Sensitive, Room Temperature Gas Sensor Based on Polyaniline-Multiwalled Carbon Nanotubes (PANI/MWCNTs) Nanocomposite for Trace-Level Ammonia Detection. Sensors Chem. 2015. 1523-1534. Actuators 221. https://doi.org/10.1016/j.snb.2015.08.002.
- (29)Das, T. K.; Prusty, S. Review on Conducting Polymers and Their Applications. Polym. Plast. Technol. Eng. 2012, 51 (14), 1487-1500. https://doi.org/10.1080/03602559.2012.710697.
- (30)Pandey, S. Highly Sensitive and Selective Chemiresistor Gas/Vapor Sensors Based on Polyaniline Nanocomposite: A Comprehensive Review. J. Sci. Adv. Mater. Devices 2016, 1 (4), 431-453. https://doi.org/10.1016/j.jsamd.2016.10.005.
- (31)Mir, M. A.; Bhat, M. A.; Naikoo, R. A.; Bhat, R. A.; khan, M.; Shaik, M.; Kumar, P.; Sharma, P. K.; Tomar, R. Utilization of Zeolite/Polymer Composites for Gas Sensing: A Review. Sensors Actuators B Chem. 2017, 242, 1007-1020. https://doi.org/10.1016/j.snb.2016.09.152.
- (32)Stassen, I.; Burtch, N.; Talin, A.; Falcaro, P.; Allendorf, M.; Ameloot, R. An Updated Roadmap for the Integration of Metal-Organic Frameworks with Electronic Devices and Chemical Sensors. Chem. Soc. Rev. 2017, 46 (11), 3185-3241. https://doi.org/10.1039/c7cs00122c.
- (33)Petit, C.; Bandosz, T. J. MOF-Graphite Oxide Composites: Combining the Uniqueness of Graphene Layers and Metal-Organic Frameworks. Adv. Mater. 2009, 21 (46), 4753-4757.

- https://doi.org/10.1002/adma.200901581. Peng, N.; Zhang, Q.; Chow, C. L.; Tan, O. K.; Marzari, N. Sensing
- (34)Mechanisms for Carbon Nanotube Based NH₃ Gas Detection. Nano Lett. 2009. 1626-1630. (4),https://doi.org/10.1021/nl803930w.
- (35)Sharma, S.; Hussain, S.; Singh, S.; Islam, S. S. MWCNT-Conducting Polymer Composite Based Ammonia Gas Sensors: A New Approach for Complete Recovery Process. Sensors Chem. 2014, 213-219. https://doi.org/10.1016/j.snb.2013.12.050.
- (36)Rigoni, F.; Tognolini, S.; Borghetti, P.; Drera, G.; Pagliara, S.; Goldoni, A.; Sangaletti, L. Enhancing the Sensitivity of Chemiresistor Gas Sensors Based on Pristine Carbon Nanotubes to Detect Low-Ppb Ammonia Concentrations in the Environment. Analyst 2013, 138 (24), 7392. https://doi.org/10.1039/c3an01209c.
- (37)Septiani, N. L. W.; Yuliarto, B. Review-The Development of Gas Sensor Based on Carbon Nanotubes. J. Electrochem. Soc. 2016. B97-B106. 163 (3), https://doi.org/10.1149/2.0591603jes.
- (38)Zaporotskova, I. V; Boroznina, N. P.; Parkhomenko, Y. N.; Kozhitov, L. V. Carbon Nanotubes: Sensor Properties. A Review. Mod. Electron. Mater. 2016, 2 (4), 95-105. https://doi.org/10.1016/j.moem.2017.02.002.
- (39)Varghese, S. S.; Lonkar, S.; Singh, K. K.; Swaminathan, S.; Abdala, A. Recent Advances in Graphene Based Gas Sensors. Sensors Actuators B Chem. 2015, *218*, 160-183. https://doi.org/10.1016/j.snb.2015.04.062.
- (40)Chen, G.; Paronyan, T. M.; Harutyunyan, A. R. Sub-Ppt Gas Detection with Pristine Graphene. Appl. Phys. Lett. 2012, 101 (5), 53119. https://doi.org/10.1063/1.4742327.
- (41)Jiang, X.; Qavi, A. J.; Huang, S. H.; Yang, L. Whispering-Gallery Matter 2020, Sensors. 371-392. (2), https://doi.org/10.1016/j.matt.2020.07.008.
- (42)Armani, D. K.; Kippenberg, T. J.; Spillane, S. M.; Vahala, K. J. Ultra-High-Q Toroid Microcavity on a Chip. Nature 2003, 421 (6926), 925-928. https://doi.org/10.1038/nature01371.
- (43)Lee, H.; Chen, T.; Li, J.; Yang, K. Y.; Jeon, S.; Painter, O.; Vahala, K. J. Chemically Etched Ultrahigh-Q Wedge-Resonator on a Silicon Chip. Nat. Photonics 2012, 6 (6), 369-373. https://doi.org/10.1038/nphoton.2012.109.
- (44)Xu, Q.; Schmidt, B.; Pradhan, S.; Lipson, M. Micrometre-Scale Silicon Electro-Optic Modulator. Nature 2005, 435 (7040), 325-327. https://doi.org/10.1038/nature03569.
- (45)Gondarenko, A.; Levy, J. S.; Lipson, M. High Confinement Micron-Scale Silicon Nitride High Q Ring Resonator. Opt. 2009, Express 17 (14),11366. https://doi.org/10.1364/oe.17.011366.
- (46)Li, C.; Lohrey, T.; Nguyen, P.-D.; Min, Z.; Tang, Y.; Ge, C.; Sercel, Z. P.; McLeod, E.; Stoltz, B. M.; Su, J. Part-per-Trillion Trace Selective Gas Detection Using Frequency Locked Whispering-Gallery Mode Microtoroids. ACS Appl. Mater. Interfaces 2022. https://doi.org/10.1021/ACSAMI.2C11494/SUPPL_FILE/A M2C11494_SI_001.PDF.
- Schmidt, S.; Flueckiger, J.; Wu, W.; Grist, S. M.; Fard, S. T.; (47)Donzella, V.; Khumwan, P.; Thompson, E. R.; Wang, Q.; Kulik, P.; Wang, X.; Sherwali, A.; Kirk, J.; Cheung, K. C.; Chrostowski, L.; Ratner, D. Improving the Performance of Silicon Photonic Rings, Disks, and Bragg Gratings for Use in Label-Free Biosensing. https://doi.org/10.1117/12.2062389 2014, 9166, 71-108. https://doi.org/10.1117/12.2062389.
- (48) Selvaraja, S. K.; Jaenen, P.; Bogaerts, W.; Van Thourhout, D.; Dumon, P.; Baets, R. Fabrication of Photonic Wire and Crystal Circuits in Silicon-on-Insulator Using 193-Nm Optical Lithography. J. Light. Technol. 2009, 27 (18), 4076-4083. https://doi.org/10.1109/jlt.2009.2022282.
- (49)Sree, S. P.; Dendooven, J.; Smeets, D.; Deduytsche, D.; Aerts, A.; Vanstreels, K.; Baklanov, M. R.; Seo, J. W.; Temst, K.; Vantomme, A.; Detavernier, C.; Martens, J. A. Spacious and Mechanically Flexible Mesoporous Silica Thin Film Composed of an Open Network of Interlinked Nanoslabs. I. Mater. Chem. **2011**, 21 (21), 7692. https://doi.org/10.1039/c1jm10270b.
- (50)Baklanov, M. R.; Mogilnikov, K. P.; Polovinkin, V. G.; Dultsev, F.

- N. Determination of Pore Size Distribution in Thin Films by Ellipsometric Porosimetry. *J. Vac. Sci. & Distribution of Pore Size Distribution in Thin Films by Ellipsometric Porosimetry. J. Vac. Sci. & Distribution of Pore Size Distribution in Thin Films by Ellipsometric Porosimetry. <i>J. Vac. Sci. & Distribution in Thin Films by Ellipsometric Porosimetry. J. Vac. Sci. & Distribution in Thin Films by Ellipsometric Porosimetry. <i>J. Vac. Sci. & Distribution in Thin Films by Ellipsometric Porosimetry. J. Vac. Sci. & Distribution in Thin Films by Ellipsometric Porosimetry. <i>J. Vac. Sci. & Distribution in Thin Films by Ellipsometric Porosimetry. J. Vac. Sci. & Distribution in Thin Films by Ellipsometric Porosimetry. <i>J. Vac. Sci. & Distribution in Thin Films by Ellipsometric Porosimetry. J. Vac. Sci. & Distribution in Thin Films by Ellipsometric Porosimetry. <i>J. Vac. Sci. & Distribution in Thin Films by Ellipsometric Porosimetry. J. Vac. Sci. & Distribution in Thin Films by Ellipsometric Porosimetry. <i>J. Vac. Sci. & Distribution in Thin Films by Ellipsometric Porosimetry. J. Vac. Sci. & Distribution in Thin Films by Ellipsometric Porosimetry. <i>J. Vac. Sci. & Distribution in Thin Films by Ellipsometric Porosimetry. J. Vac. Sci. & Distribution in Thin Films by Ellipsometric Porosimetry. <i>J. Vac. Sci. & Distribution in Thin Films by Ellipsometric Porosimetry. J. Vac. Sci. & Distribution in Thin Films by Ellipsometric Porosimetry. <i>J. Vac. Sci. & Distribution in Thin Films by Ellipsometric Porosimetry. Distribution in Thin Films by Ellipsometric Porosimetry. <i>J. Vac. Sci. & Distribution in Thin Films by Ellipsometric Porosimetry. Distribution in Thin Films by Ellipsometric Porosimetry. <i>J. Vac. Sci. & Distribution in Thin Films by Ellipsometric Porosimetry. Distribution in Thin Films by Ellipsometric Porosimetry. <i>J. Vac. Sci. & Distribution in Thin Films by Ellipsometric Porosimetry. Distribution in Thin Films by Ellipsometric Porosimetry. <i>J. Vac. Sci. & Distribution in Thin Films by Ellipsometric Porosimetry. Distribut*
- (51) Aguilar, A. D.; Forzani, E. S.; Nagahara, L. A.; Amlani, I.; Tsui, R.; Tao, N. J. A Breath Ammonia Sensor Based on Conducting Polymer Nanojunctions. *IEEE Sens. J.* **2008**, *8* (3), 269–273. https://doi.org/10.1109/jsen.2007.913137.
- (52) Heiduschka, P.; Preschel, M.; Rösch, M.; Göpel, W. Regeneration of an Electropolymerised Polypyrrole Layer for the Amperometric Detection of Ammonia. Biosens. Bioelectron. 1997, 12 (12), 1227–1231. https://doi.org/10.1016/s0956-5663(97)00066-3.

SYNOPSIS TOC : Highly porous silica-alumina films on silicon nano-photonic chips for selective NH3 detection.

